

**OptiMOS™ -T Power-Transistor**

**Features**

- N-channel - Enhancement mode
- AEC qualified
- MSL1 up to 260°C peak reflow
- 175°C operating temperature
- Green Product (RoHS compliant)
- 100% Avalanche tested

**Product Summary**

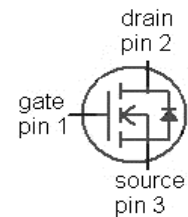
$V_{DS}$	250	V
$R_{DS(on),max}$	100	mΩ
$I_D$	17	A

PG-TO263-3-2

PG-TO220-3-1



Type	Package	Marking
IPB17N25S3-100	PG-TO263-3-2	3N25100
IPP17N25S3-100	PG-TO220-3-1	3N25100


**Maximum ratings, at  $T_j=25^\circ\text{C}$ , unless otherwise specified**

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current	$I_D$	$T_C=25^\circ\text{C}$ , $V_{GS}=10\text{ V}$	17	A
		$T_C=100^\circ\text{C}$ , $V_{GS}=10\text{V}^{1)}$	13.3	
Pulsed drain current <sup>1)</sup>	$I_{D,pulse}$	$T_C=25^\circ\text{C}$	68	
Avalanche energy, single pulse <sup>1)</sup>	$E_{AS}$	$I_D=5.4\text{A}$	54	mJ
Avalanche current, single pulse	$I_{AS}$	-	5.4	A
Reverse diode $dv/dt$	$dv/dt$	-	6	kV/ $\mu\text{s}$
Gate source voltage	$V_{GS}$	-	$\pm 20$	V
Power dissipation	$P_{tot}$	$T_C=25^\circ\text{C}$	107	W
Operating and storage temperature	$T_j$ , $T_{stg}$	-	-55 ... +175	$^\circ\text{C}$
IEC climatic category; DIN IEC 68-1	-	-	55/175/56	

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
<b>Thermal characteristics<sup>1)</sup></b>						
Thermal resistance, junction - case	$R_{thJC}$	-	-	-	1.4	K/W
Thermal resistance, junction - ambient, leaded	$R_{thJA}$	-	-	-	62	
SMD version, device on PCB	$R_{thJA}$	minimal footprint	-	-	62	
		6 cm <sup>2</sup> cooling area <sup>2)</sup>	-	-	40	

**Electrical characteristics, at  $T_j=25^\circ\text{C}$ , unless otherwise specified**
**Static characteristics**

Drain-source breakdown voltage	$V_{(BR)DSS}$	$V_{GS}=0V, I_D=1mA$	250	-	-	V
Gate threshold voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=54\mu A$	2.0	3.0	4.0	
Zero gate voltage drain current	$I_{DSS}$	$V_{DS}=250V, V_{GS}=0V$	-	0.01	1	$\mu A$
		$V_{DS}=250V, V_{GS}=0V, T_j=125^\circ\text{C}^{2)}$	-	1	100	
Gate-source leakage current	$I_{GSS}$	$V_{GS}=20V, V_{DS}=0V$	-	10	100	nA
Drain-source on-state resistance	$R_{DS(on)}$	$V_{GS}=10V, I_D=17A$	-	85	100	m $\Omega$

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

**Dynamic characteristics<sup>1)</sup>**

Input capacitance	$C_{iss}$	$V_{GS}=0V, V_{DS}=25V,$ $f=1MHz$	-	1133	1500	pF
Output capacitance	$C_{oss}$		-	480	625	
Reverse transfer capacitance	$C_{rss}$		-	11	23	
Turn-on delay time	$t_{d(on)}$	$V_{DD}=125V, V_{GS}=10V,$ $I_D=17A, R_G=3.3\Omega$	-	4.4	-	ns
Rise time	$t_r$		-	3.7	-	
Turn-off delay time	$t_{d(off)}$		-	7.5	-	
Fall time	$t_f$		-	1.2	-	

**Gate Charge Characteristics<sup>1), 3)</sup>**

Gate to source charge	$Q_{gs}$	$V_{DD}=200V, I_D=17A,$ $V_{GS}=0$ to 10V	-	5	7	nC
Gate to drain charge	$Q_{gd}$		-	2.4	4.8	
Gate charge total	$Q_g$		-	14	19	
Gate plateau voltage	$V_{plateau}$		-	4.6	-	V

**Reverse Diode**

Diode continuous forward current <sup>1)</sup>	$I_S$	$T_C=25^\circ C$	-	-	17	A
Diode pulse current <sup>1)</sup>	$I_{S,pulse}$		-	-	56	
Diode forward voltage	$V_{SD}$	$V_{GS}=0V, I_F=17A,$ $T_J=25^\circ C$	-	0.9	1.3	V
Reverse recovery time <sup>1)</sup>	$t_{rr}$	$V_R=125V, I_F=17A,$ $di_F/dt=100A/\mu s$	-	120	-	ns
Reverse recovery charge <sup>1)</sup>	$Q_{rr}$		-	525	-	nC

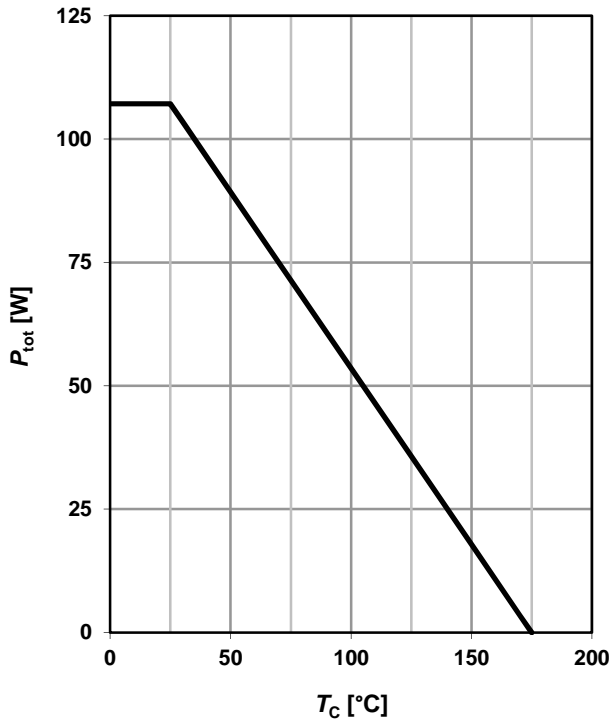
<sup>1)</sup> Defined by design. Not subject to production test.

<sup>2)</sup> Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm<sup>2</sup> (one layer, 70 μm thick) copper area for drain connection. PCB is vertical in still air.

<sup>3)</sup> Devices thermal performance determined according to EIA JESD 51-14  
"Transient Dual Interface Test Method For The Measurement Of The Thermal Resistance"

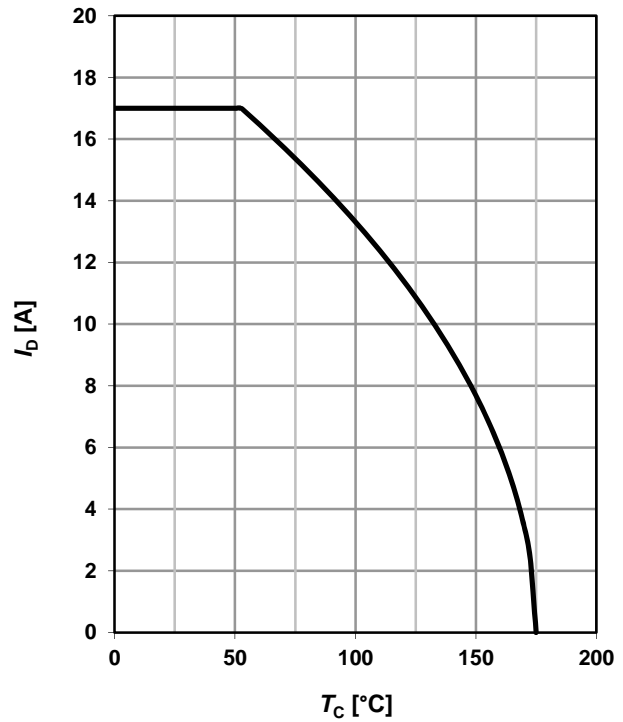
**1 Power dissipation**

$P_{tot} = f(T_C); V_{GS} \geq 6\text{ V}$



**2 Drain current**

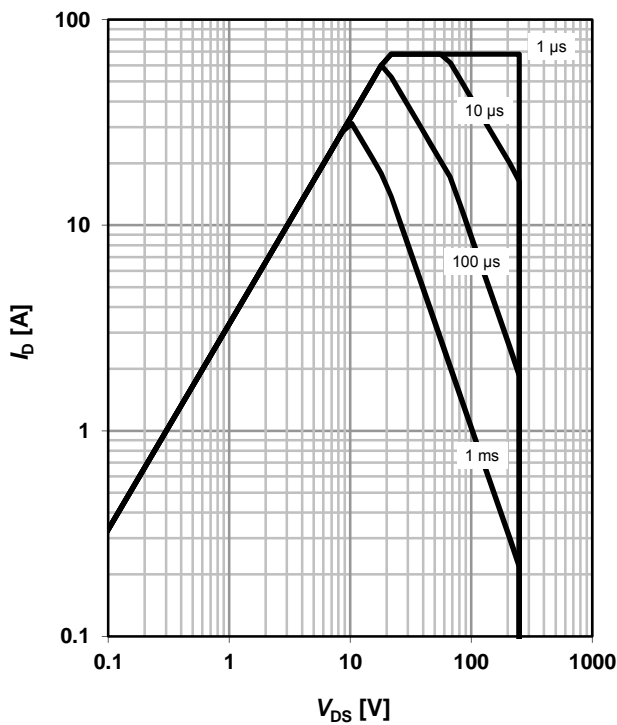
$I_D = f(T_C); V_{GS} \geq 6\text{ V}; \text{SMD}$



**3 Safe operating area**

$I_D = f(V_{DS}); T_C = 25\text{ °C}; D = 0; \text{SMD}$

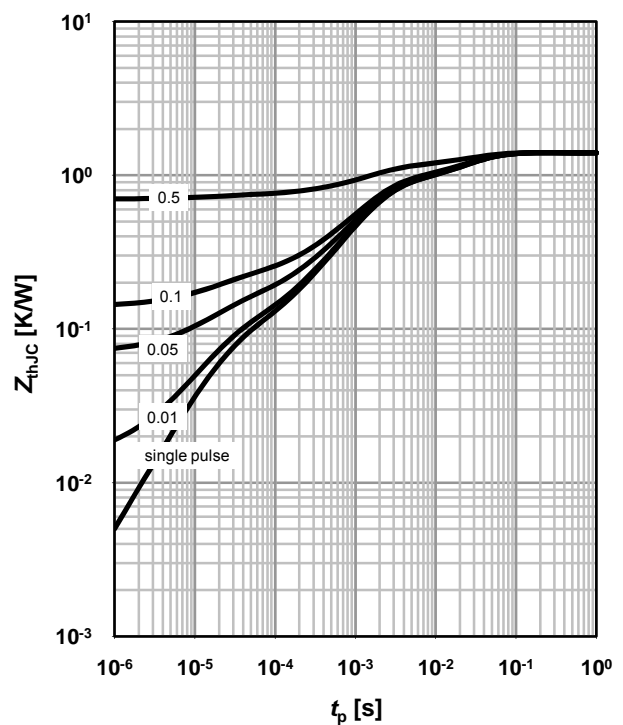
parameter:  $t_p$



**4 Max. transient thermal impedance**

$Z_{thJC} = f(t_p)$

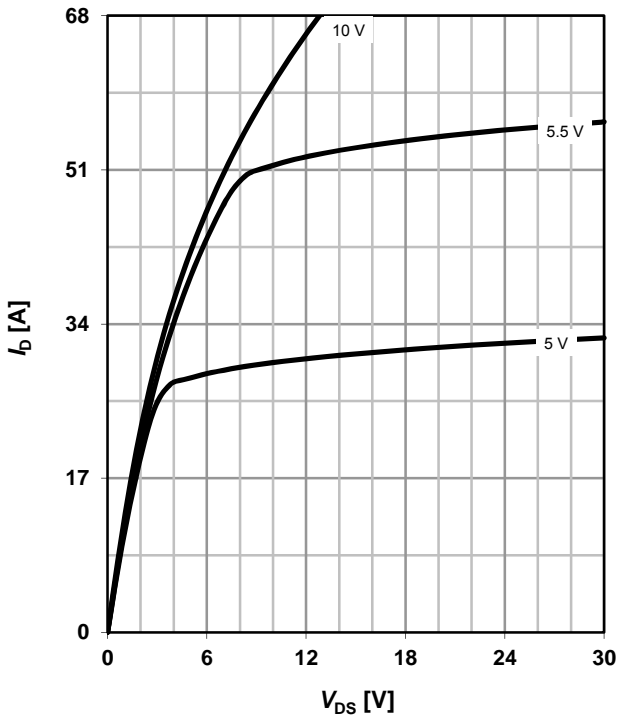
parameter:  $D = t_p/T$



**5 Typ. output characteristics**

$I_D = f(V_{DS}); T_j = 25\text{ °C}; \text{SMD}$

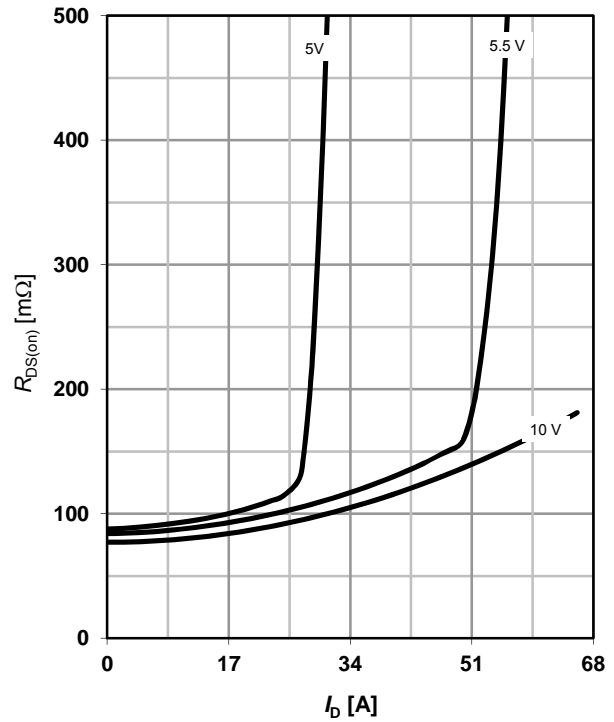
parameter:  $V_{GS}$



**6 Typ. drain-source on-state resistance**

$R_{DS(on)} = f(I_D); T_j = 25\text{ °C}; \text{SMD}$

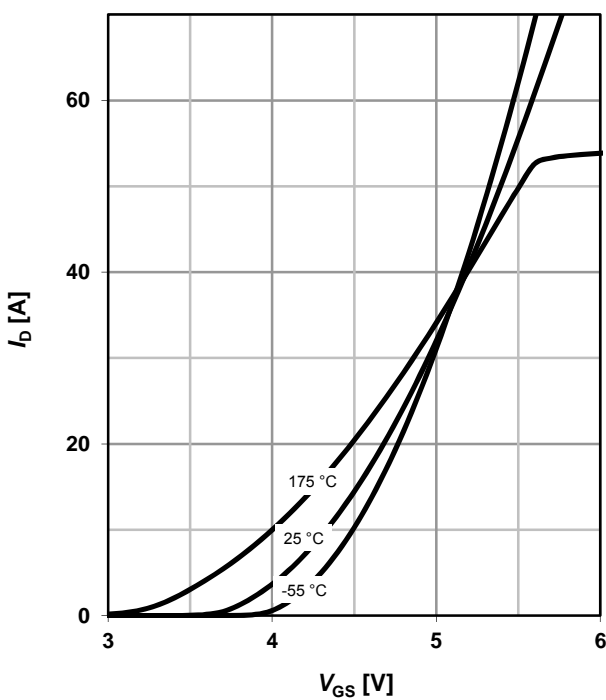
parameter:  $V_{GS}$



**7 Typ. transfer characteristics**

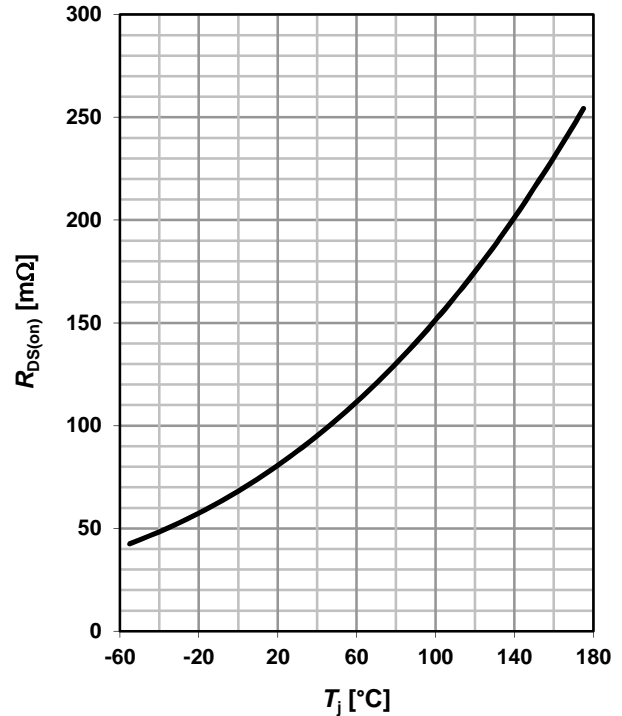
$I_D = f(V_{GS}); V_{DS} = 25V$

parameter:  $T_j$



**8 Typ. drain-source on-state resistance**

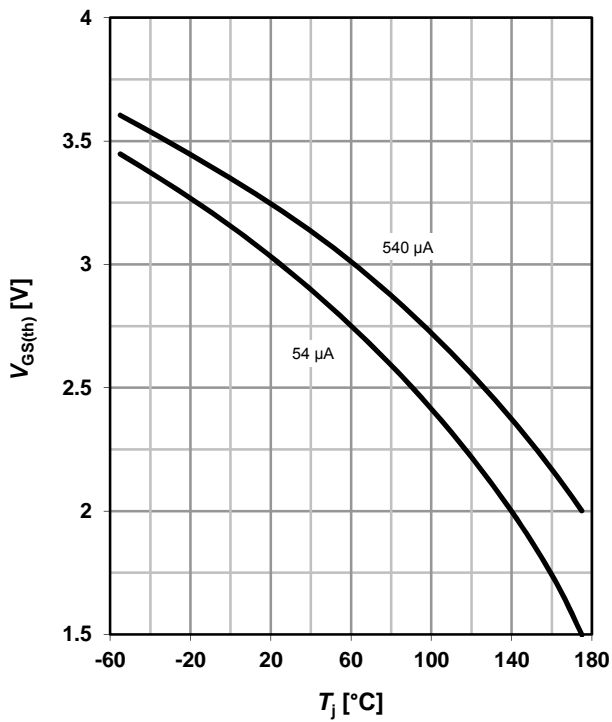
$R_{DS(on)} = f(T_j); I_D = 17\text{ A}; V_{GS} = 10\text{ V}; \text{SMD}$



**9 Typ. gate threshold voltage**

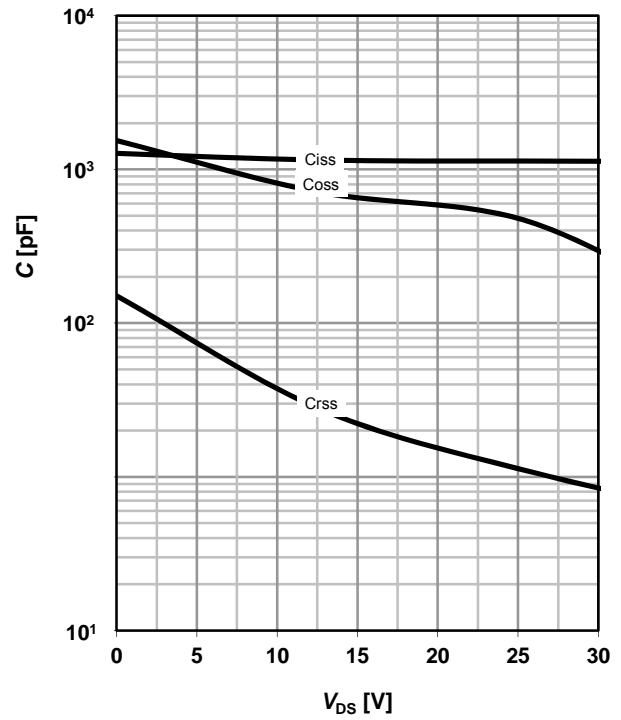
$V_{GS(th)} = f(T_j); V_{GS} = V_{DS}$

parameter:  $I_D$



**10 Typ. capacitances**

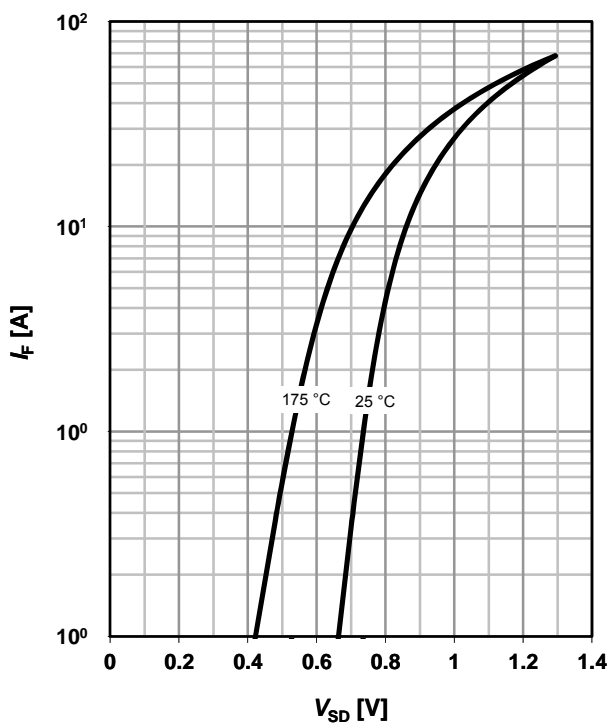
$C = f(V_{DS}); V_{GS} = 0 V; f = 1 MHz$



**11 Typical forward diode characteristics**

$I_F = f(V_{SD})$

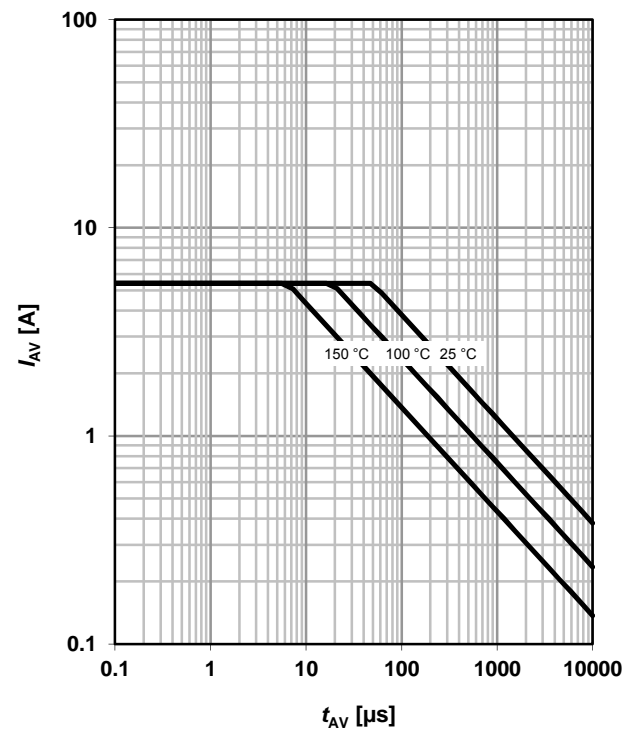
parameter:  $T_j$



**12 Avalanche characteristics**

$I_{AS} = f(t_{AV})$

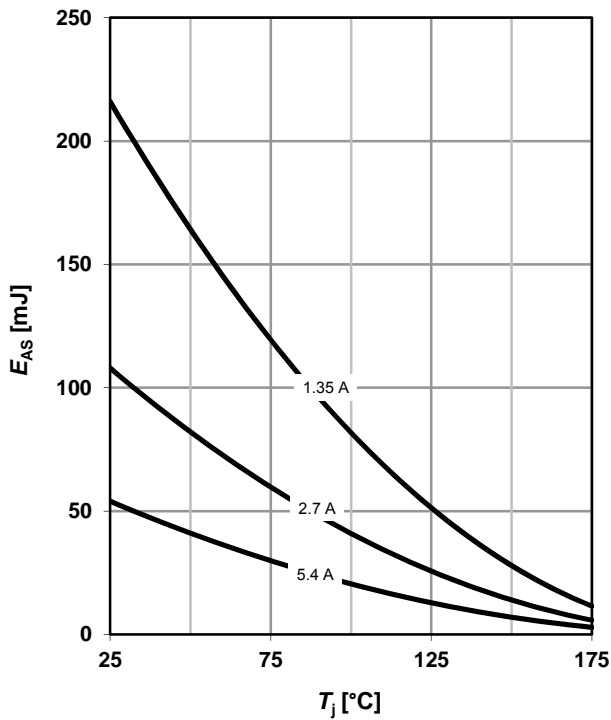
parameter:  $T_{j(start)}$



**13 Avalanche energy**

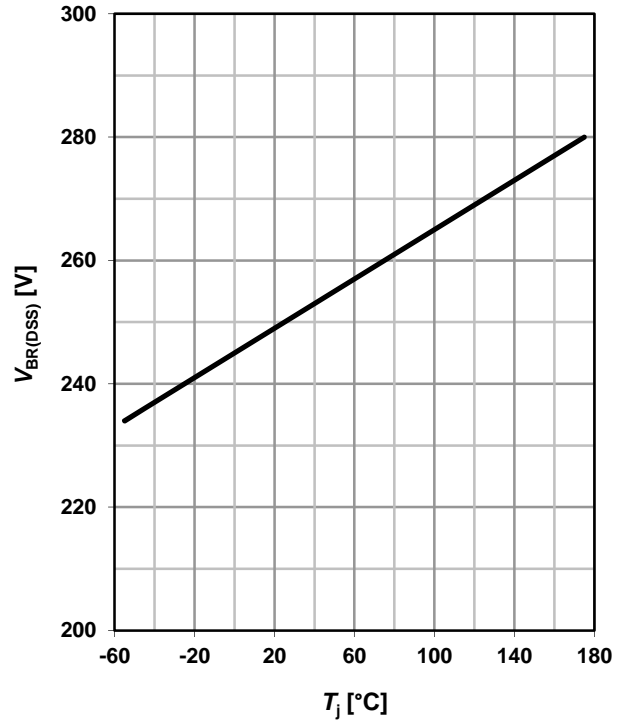
$$E_{AS} = f(T_j)$$

parameter:  $I_D$



**14 Drain-source breakdown voltage**

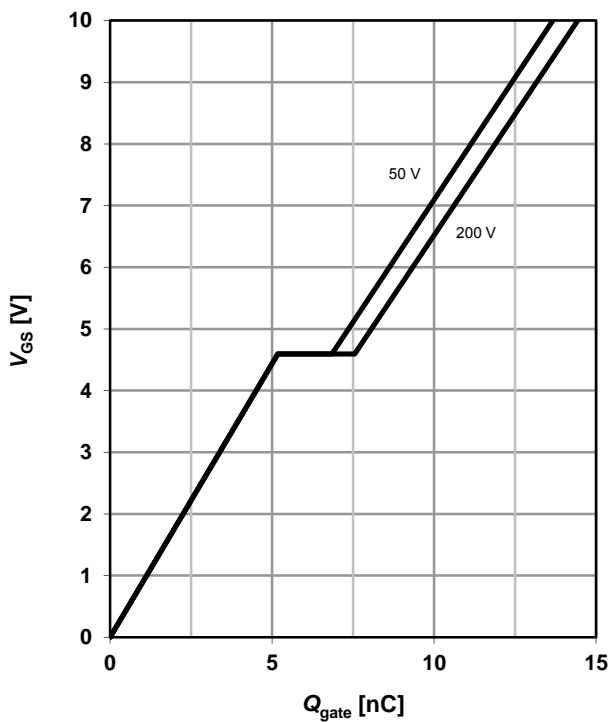
$$V_{BR(DSS)} = f(T_j); I_D = 1 \text{ mA}$$



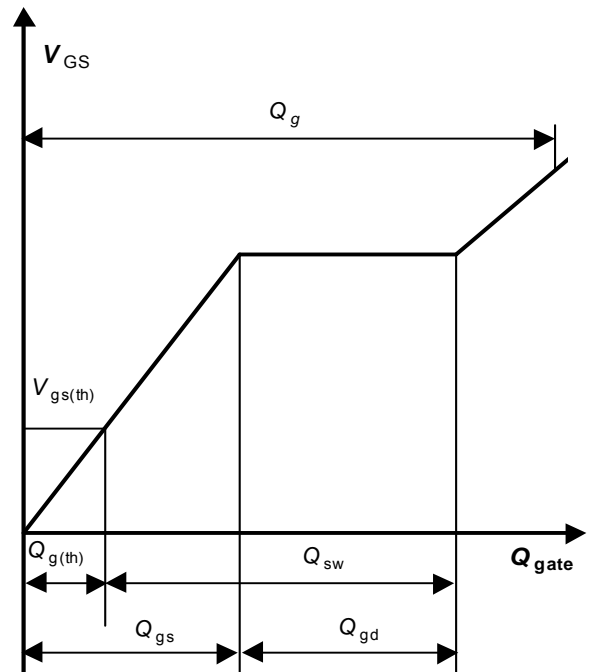
**15 Typ. gate charge**

$$V_{GS} = f(Q_{gate}); I_D = 17 \text{ A pulsed}$$

parameter:  $V_{DD}$



**16 Gate charge waveforms**



**Published by**  
**Infineon Technologies AG**  
**81726 Munich, Germany**

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## Revision History

Version	Date	Changes
Revision 1.0	18.10.2012	Final Data Sheet
Revision 1.1	12.05.2013	Update of diagram 5 and 6

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